Application/Control No. O9/934,541 Examiner Daniel D Abebe Applicant(s)/Patent Under Reexamination VAUDREY ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

<u> </u>		Document Number	Date		T
*		Country Code-Number-Kind Code	MM-YYYY	Name	Classification
	Α	US-6167375	12-2000	Miseki et al.	704/229
	В	US-			
	С	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	Н	US-			
	ı	US-			
	J	US-			
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FOREIGN PATENT DOCUMENTS

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	N					
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NON-PATENT DOCUMENTS

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